PCN Number:			20180830000			PCN Date:	August 31, 2018				
Title: Datasheet for THS			r THS	3491							
Customer Contact: F			PCN	PCN Manager			Dept:		pt:	Quality Services	
Change Type:											
Assembly Site				Design				Wafer	Bump Site		
Assembly Process				\boxtimes	Data Shee	et			Wafer	Bump Material	
Assembly Materials					Part numb	oer change			Wafer	Bump Process	
■ Mechanical Specification					Test Site				Wafer	Fab Site	
Packing/Shipping/Labeling			ng	Test Process				Wafer	Fab Materials		
☐ Wafer Fab Process					Fab Process						
	Notification Details										

Notification

Description of Change:

Texas Instruments Incorporated is announcing an information only notification.

The product datasheet(s) is being updated as summarized below.

The following change history provides further details.



THS3491

SBOS875B - AUGUST 2017 - REVISED JULY 2018

Cl	anges from Revision A (March 2018) to Revision B	Page
	Changed resistor values in Typical Arbitrary Waveform Generator Output Drive Circuit from 49.9 Ω to 40.2 Ω	1
	Changed resistor values in Typical Arbitrary Waveform Generator Output Drive Circuit from 24.9 Ω to 30 Ω	1
	Changed "T _A = 25°C" to "T _A ≈ 25°C" in <i>Electrical Characteristics</i> : ±15 V condition statement	6
	Changed "100% tested at 25°C" to "100% tested at ≈ 25°C" in the footnote of Electrical Characteristics: ±15 V	6
•	Added "DDA package only" in Test Conditions column for "Vos" specification	6
•	Added new Vos specifiction line for RGT package	6
	Added min/max values to "R _{FB TRACE} " specification	
•	Changed units from "pF \parallel k Ω " to "k Ω \parallel pF" and changed typical spec accordingly	7
•	Added min/max values to "T _{J SENSE} 25°C value" specification	8
	Changed "T _{J SENSE} temperature coefficient" specification's typical value from 3 mV/°C to 3.2 mV/°C	
•	Added min/max values to "T _{J_SENSE} input impedance" specification	8
	Changed "T _A = 25°C" to "T _A ≈ 25°C" in <i>Electrical Characteristics</i> : ±7.5 V condition statement	
	Changed "100% tested at 25°C" to "100% tested at ≈ 25°C" in the footnote of <i>Electrical Characteristics</i> : ±7.5 V	
	Added "DDA package only" in Test Conditions column for "Vos" specification	
	Added new V _{OS} specifiction line for RGT package	
	Changed units from "pF $k\Omega$ " to " $k\Omega$ pF" and changed typical values accordingly	
	Added min/max values to "T _{J SENSE} 25°C value" specification	
	Added min/max values to "T _{J_SENSE} input impedance" specification	
	Changed "T _A = 25°C" to "T _A ≈ 25°C" in <i>Typical Characteristics</i> : ±15 V condition statement	
•	Changed Z _{OL} low frequency value from 160 dB to 138 dB in Open-Loop Transimpedance Gain and Phase vs Frequency	
	Changed Overdrive Recovery Time grid lines and added gain information	
	Added T _{J SENSE} Voltage vs Ambient Temperature	
	Changed "T _A = 25°C" to "T _A ≈ 25°C" in <i>Typical Characteristics</i> : ±7.5 V condition statement	
	Changed Overdrive Recovery Time grid lines and added gain information	
•	Corrected polarity of negative supply capacitor in Wideband Noninverting Gain Configuration (5 V/V)	
•	Corrected negative supply capacitor polarity in Wideband Inverting Gain Configuration (5 V/V)	
•	Added "R _{ISO} " to "1 Ω" in <i>Driving a Large Capacitive Load Using an Output Series Isolation Resistor</i>	
•	Added 1-kΩ resistor to Driving a Large Capacitive Load Using an Output Series Isolation Resistor	
•	Changed supply values from ±15 V to ±7.5 V in Video Distribution Amplifier Application	
	Changed R_{S2} values from 100 Ω to 40.2 Ω in Load-Sharing Driver Application	
•	Added 30-Ω resistor to Load-Sharing Driver Application	
•	Added text to Design Requirements and Detailed Design Procedure sections	32
	Added Application Curves section	33

The datasheet number will be changing.			
Device Family	Change From:	Change To:	
THS3491	SBOS875A	SBOS875B	

These changes may be reviewed at the datasheet links provided.

http://www.ti.com/product/THS3491

Reason for Change:

To accurately reflect device characteristics.

Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):

No anticipated impact. This is a specification change announcement only. There are no changes to the actual device.

Changes to product identification resulting from this PCN:

None.

Product Affected:

THS3491IDDAR	THS3491IDDAT	THS3491IRGTR	THS3491IRGTT
XTHS3491IRGTR			

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
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